

Search Notes



Application/Control No.

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Examiner

Tan V. Mai

Applicant(s)/Patent under
Reexamination

KOSHY ET AL.

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
708	620-632	9/18/2007	MAI

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	9/18/2007	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner